



SLP10N70S / SLF10N70S 700V N-Channel MOSFET

General Description

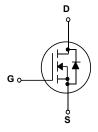
This Power MOSFET is produced using Msemitek's advanced planar stripe DMOS technology. This advanced technology has been especially tailored to minimize on-state resistance, provide superior switching performance, and withstand high energy pulse in the avalanche and commutation mode. These devices are well suited for high efficiency switched mode power supplies, active power factor correction based on half bridge topology.

Features

- N-Channel:700V 10A $R_{DS(on)Typ}\text{= }850\text{m}\Omega\text{@V}_{GS}\text{= }10\text{ V}$
- Very Low On-resistance R_{DS(ON)}
- Low Crss
- Fast switching
- 100% avalanche tested
- Improved dv/dt capability







Absolute Maximum Ratings

T_C = 25°C unless otherwise noted

Symbol	Parameter	SLP10N70S / SLF10N70S	Units
V_{DSS}	Drain-Source Voltage	700	V
	Drain Current - Continuous (T _C = 25°C)	10	Α
ID	- Continuous (T _C = 100°C)	6.0	Α
I _{DM}	Drain Current - Pulsed (Note 1)	40	Α
V_{GSS}	Gate-Source Voltage	±30	V
Eas	Single Pulsed Avalanche Energy	332	mJ
P _D	Power Dissipation (T _C = 25°C)	35.0	W
Rejc	Thermal Resistance, Junction to Case	4.5	°C/W
T _J , T _{STG}	Operating and Storage Temperature Range	-55 to +150	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds	300	°C

^{*} Drain current limited by maximum junction temperature.

Units

Max

-100

Package Marking

Part Number	Top Marking	Package	Packing Method	MOQ	QTY
SLP10N70S	SLP10N70S	TO-220C	Tube	1000	5000
SLF10N70S	SLF10N70S	TO-220F	Tube	1000	5000

Electrical Characteristics

Parameter

Gate-Body Leakage Current, Reverse

T_C = 25°C unless otherwise noted

Test Conditions

Min

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Off Characteristics							
BV _{DSS}	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = 250 uA	700			V	
lasa	Zero Gate Voltage Drain Current	V _{DS} =700 V, V _{GS} = 0 V			1	uA	
I _{DSS}		V _{DS} = 560V, T _C = 125°C			10	uA	
Igsse	Gate-Body Leakage Current, Forward	V _{GS} =30V. V _{DS} = 0 V			100	nA	

 $V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$

On Characteristics

Symbol

 I_{GSSR}

V _{GS(}	Gate Threshold Voltage	$V_{DS} = V_{GS}$, $I_D = 250 \text{ uA}$	2	-	4	V
R _{DS(}	Static Drain-Source On-Resistance	V _{GS} = 10 V, I _D =5 A		0.85	1.15	Ω

Dynamic Characteristics

Ciss	Input Capacitance		1	1600	1	pF
Coss	Output Capacitance	V _{DS} =25 V, V _{GS} = 0 V, f = 1.0 MHz	1	95	1	pF
C _{rss}	Reverse Transfer Capacitance			20	-	pF

Switching Characteristics

t _{d(on)}	Turn-On Delay Time		-	23.5	-	ns
tr	Turn-On Rise Time	V _{DS} = 350V,	-	20.2	-	ns
$t_{d(off)}$	Turn-Off Delay Time	$R_G = 25\Omega$, $I_D = 10A$	-	121	-	ns
t _f	Turn-Off Fall Time	ĺ	-	38	-	ns
Q_g	Total Gate Charge	$V_{DS} = 560V$, $I_{D} = 10A$,	-	28	-	nC
Qgs	Gate-Source Charge	V _{GS} = 10V	-	8	-	nC
Q_{gd}	Gate-Drain Charge			15.5		nC

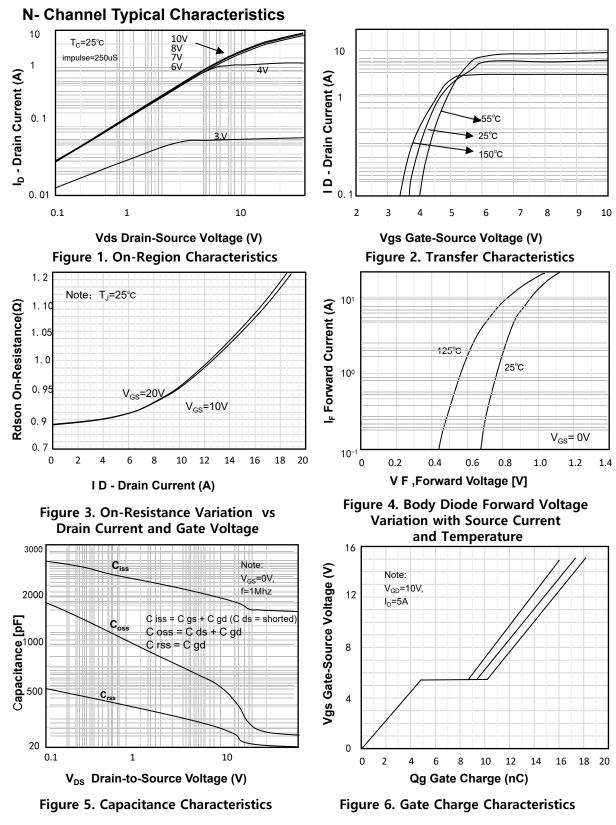
Drain-Source Diode Characteristics and Maximum Ratings

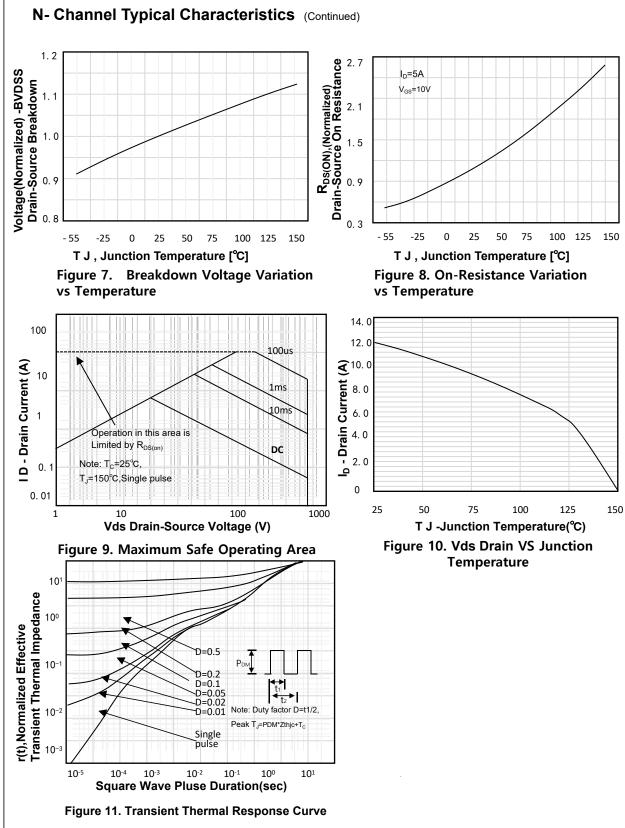
Is	Maximum Continuous Drain-Source Diode Forward Current	 	10	Α
I _{SM}	Maximum Pulsed Drain-Source Diode Forward Current	 -	40	Α
V _{SD}	Drain to Source Diode Forward Voltage, V GS = 0V, I SD = 10A, T J = 25°C	 -	1.2	V
t _{rr}	Reverse Recovery Time &T _J = 25°C, IF = 20A di/dt = 100A/µs	 556	-	nS
Qrr	Reverse Recovery Charge & T _J = 25°C, IF = 20A di/dt = 100A/µs	 5.8	-	nC

Notes:

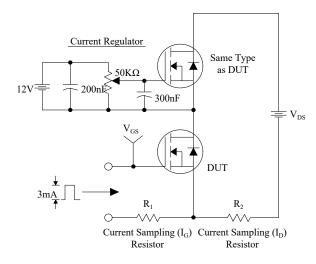
- 1. Repetitive Rating: Pulse Width Limited by Maximum Junction Temperature
- 2. EAS condition: T_J =25°C, V_{DD} =50V, V_G =10V, R G =25 Ω , L=0.5mH, I_{AS} =10A
- 3. Pulse Test: Pulse Width≤300µs, Duty Cycle≤0.5%

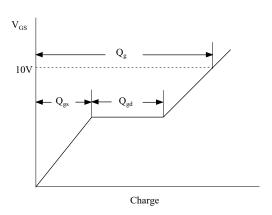
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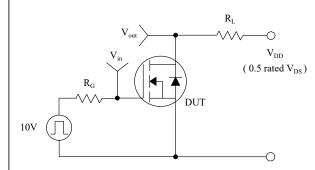


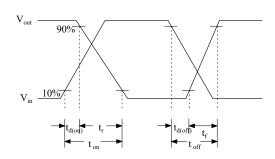
Gate Charge Test Circuit & Waveform



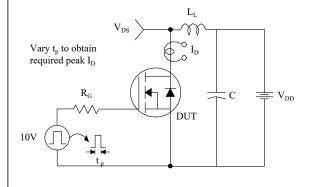


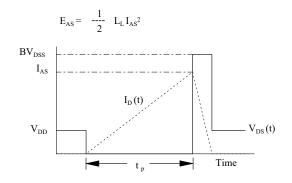
Resistive Switching Test Circuit & Waveforms





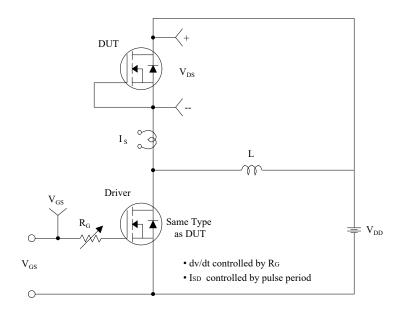
Unclamped Inductive Switching Test Circuit & Waveforms

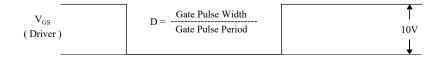


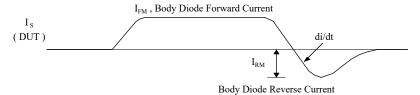


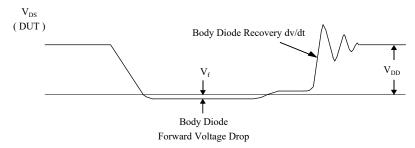
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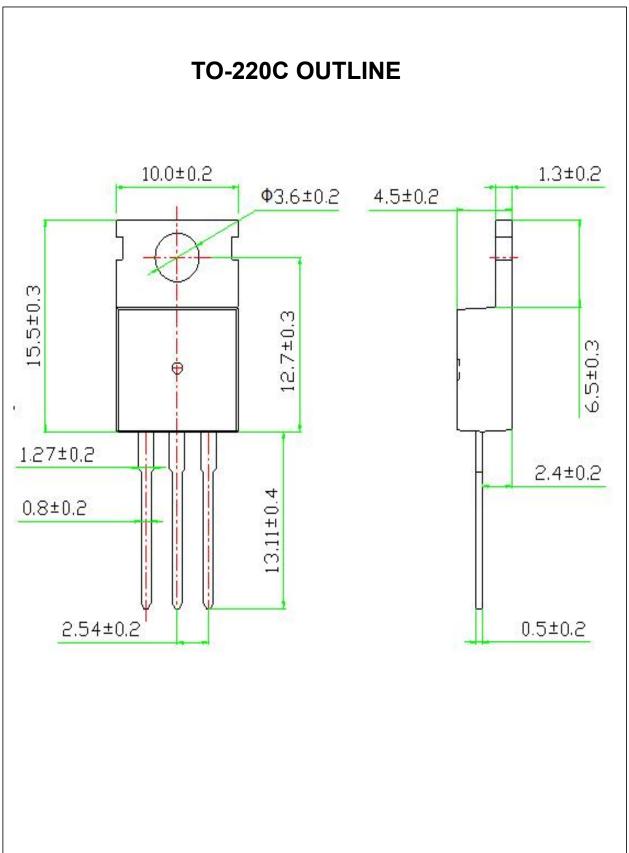
Peak Diode Recovery dv/dt Test Circuit & Waveforms

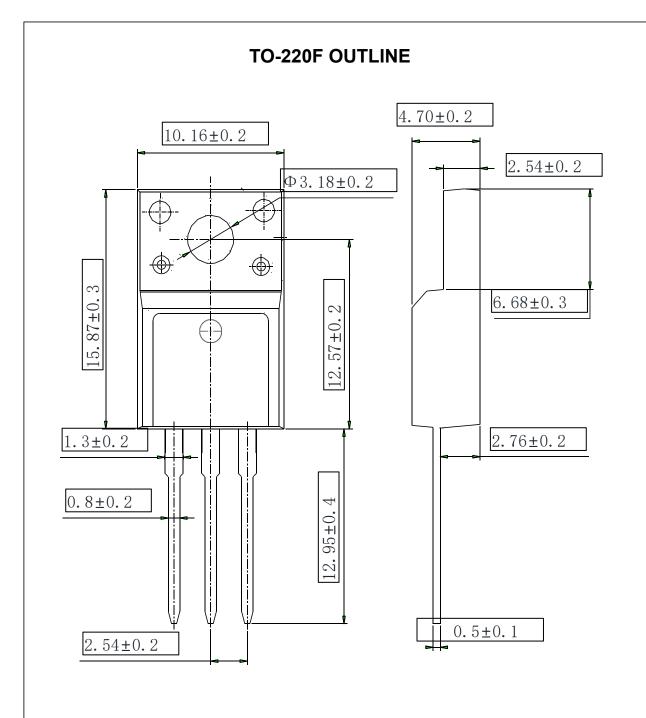












NOTE:

1The plastic package is not marked as smooth surfaceRa=0.1;Subglossy surfaceRa=0.8 2.Undeclared tolerance \pm 0.15,Unmarked filletRmax=0.25

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